

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Hideaki Kuwabara et al. Art Unit : 2822
Serial No. : 10/735,767 Examiner : Kevin Picardat
Filed : December 16, 2003 Conf. No. : 4086
Title : SEMICONDUCTOR DEVICE AND METHOD FOR MANUFACTURING THE
SAME

MAIL STOP RCE

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

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INFORMATION DISCLOSURE STATEMENT

OFFICE OF PETITIONS

Applicants request consideration of the references listed on the attached PTO-1449 form.

Under 37 C.F.R. § 1.98 (a)(2)(ii), only copies of foreign patent documents and/or non-patent literature are enclosed. Copies of any listed U.S. patents or U.S. patent application publications can be provided upon request.

This filing is being made with the filing of a Request for Continued Examination. No fee is required.

Respectfully submitted,

Date: June 29, 2007

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CERTIFICATE OF HANDCARRY

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June 29, 2007

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Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 12732-189001	Application No. 10/735,767
Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Hideaki Kuwabara et al.	
		Filing Date December 16, 2003	Group Art Unit 2822

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	2004/0263712	12-30-2004	Yamazaki			07-22-2004
	AB	2005/0070038	03-31-2005	Yamazaki			10-21-2004
	AC	5,643,804	07-01-1997	Arai			05-16-1994
	AD	5,757,456	05-26-1998	Yamazaki			03-08-1996
	AE	5,877,533	03-02-1999	Arai			03-06-1997
	AF	6,410,960	06-25-2002	Arai			01-07-1999
	AG	6,998,282	02-14-2006	Yamazaki			01-27-1998
	AH	7,050,138	05-23-2006	Yamazaki			03-02-2000
	AI	7,214,555	05-08-2007	Yamazaki			08-02-2004

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	AJ							

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
	AK	

Examiner Signature	Date Considered
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	